



IC Test Unit Ring and Coaxial Probe Block

Applications

- Interconnecting unit of IC tester
- Memory and Logic IC test

Features

- High performance coaxial probe realizes superior RF characteristics.
- The socket design is suitable to various test applications and matches customer specification.
- Contact probes can be removed one by one, enabling the user to perform a maintenance.

Specifications

Contact Probe Structure	Socket and double-ended types
Pitch	2.54mm Min.
Impedance	50Ω / 75Ω
Block Material	Glass epoxy / Aluminum
Probe Layout	